

Search Notes**Application/Control No.**

10/663,671

Examiner

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Applicant(s)/Patent under Reexamination

MIYAIRI ET AL.

Art Unit

1722

SEARCHED

Class	Subclass	Date	Examiner
117	7	3/2/2006	F.H.
117	10	3/2/2006	F.H.
117	89	3/2/2006	F.H.
117	904	3/2/2006	F.H.

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
STN (hcapius, inspec, japiro, uspatall, inpadoc)	3/2/2006	F.H.
Inventors' Name Search	3/2/2006	F.H.

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner